

# P23

## Mini Burst Field Generator (E)



### Short description

The P23's interference pulse is coupled, via its tip, into tested digital IC inputs like Reset, Clock, Quartz or into the respective signal lines. The extremely thin tip of P23 is suitable for testing finest structures.

The coupling takes place capacitively inside the field generator. The tip of the P23 mini generator is positioned galvanically on the pins or signal lines to be tested. Conventional generators and test stations can be used to determine whether a device complies with the standard noise immunity required by law. However, weak spots on an assembly can not be precisely located. Detailed information about their location, susceptibility, and type of action (E-field or B-field susceptibility) are required to easily and efficiently locate them on the printed circuit board and eliminate them. Mini burst field generators are handy and can be used at the developer's own workspace.

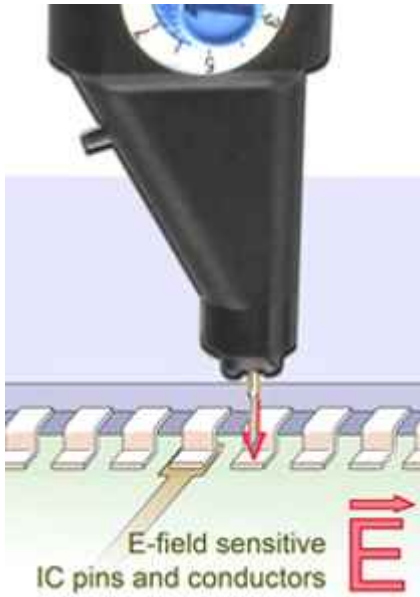
### Technical parameters

<b>Generator voltage</b>	1.2 kV
<b>Coupling capacity</b>	10 pF
<b>Pulse parameter</b>	
Rise time	1.8 ns ... 10 ns
Frequency	single / 5 kHz
Polarity	switchable
<b>Supply voltage</b>	1.5 V / AAA
<b>Weight</b>	30 g
<b>Sizes (L x W x H)</b>	(118 x 24 x 13) mm

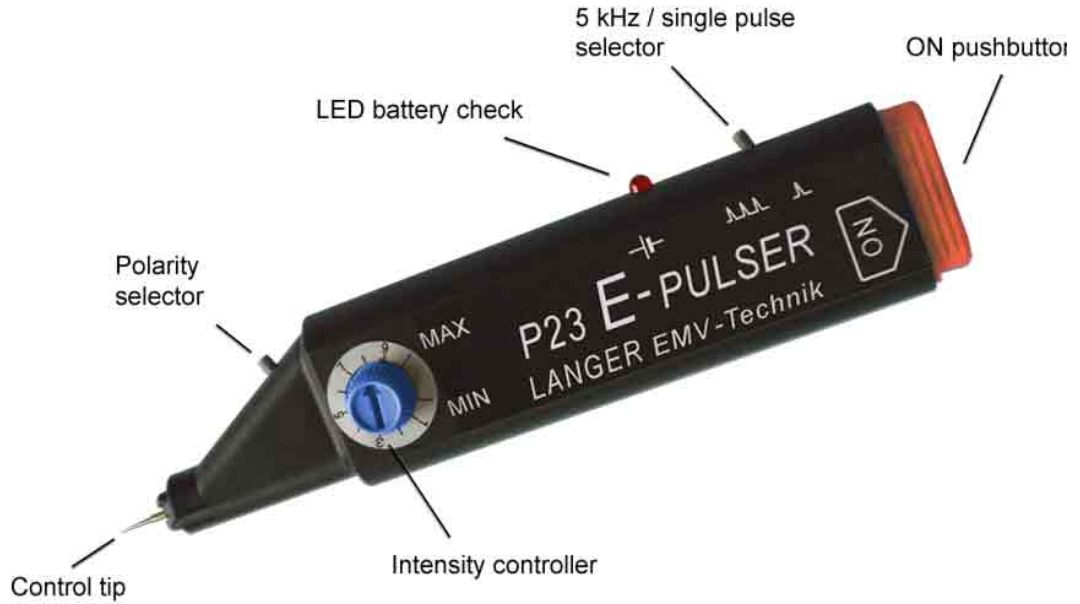
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## Measuring principles



## Design of P23 mini burst field generator



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## Application with P23

